

# Laser-accelerated proton beams as diagnostics for Cultural Heritage

M. Barberio, S. Veltri, <u>M. Scisciò</u>, A. Morabito, S. Vallieres and P. Antici







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Massimiliano Scisciò



Physics and Chemistry for Cultural Heritage: obtain a complete chemical/morphological analysis of artifacts, preventing damage





Educational, Scientific and Cultural Organization "Accessibility and preservation of cultural heritage is needed for the vitality of engagement within and across European cultures by also considering the importance of cultural heritage as strong economic driver in a post-industrial economy and its contribution to sustainable economic growth."

- funds for tens of M€ -

Chem	ical analysis:	Morphological analysis:		
XPS		SEM		
XRF		AFM		
EDX				
Photoluminescence				
PIXE	Proton-driven technique:			
Proton Induced X-ray Emission				



#### XRF/EDX analys of Van Eyck's pigments

G. Van der Snickt et al., Angew. Chem. Int. Ed. Engl. 56, 4797-4801 (2017)

EAC

PIXE: proton beams stimulate the emission X-rays, which allows performing a chemical analysis of the material.



#### A technique used for Cultural Heritage analysis



Example of PIXE to analyze the pigment's composition of The Trivulzio portrait by Antonello da Messina

- Advantage over XRF: detection of low Z elements and higher spatial precision
- Detection of elements up to 20 ppb



Analysis performed at LABEC (Florence)



#### AGLAE @ Louvre



A well established technique in many laboratories: AGLAE (France), LABEC (Florence), CENBG (Bordeaux) etc.

Drawbacks:

- large facility
- limited energy tenability (1-5 MeV)
- beam spot-size of a few tens μm
- Damages to the artifact are a concern
- extremely long measuring time (100-9000 sec) due to low proton flux



	DR-N	
	Total	Pixel
Scan size	$1 \times 1 \text{ mm}^2$	
Pixel resolution Beam charge Av. current	18 μC 8 nA	10 μm 1.8 nC
Acquisition time	35 min	210 ms
Matrix count rate Trace count rate Average counts	11 kc/s 69 kc/s	2500

L. Pichon et al., Nucl. Instr. Methods Phys. Res. B 363, 48-54 (2015)



Target Normal Sheath Acceleration (TNSA)



- Up to  $10^{13}$  protons/shot
- Proton energy of up to tens of MeV
- Short bunch duration (ps at the source)

- Laser energy of a few Joules is sufficient
- Pulse duration of tens of fs, up to ps
- Target thickness from several µm to tens of nm
- Possibly high contrast ratio (especially for thin targets)



Typical TNSA spectrum @ JLF-TITAN

Advantages of PIXE with laser-driven proton beams:

- higher charge for each shot
- higher signal-to-noise ratio allows shorter measuring times
- larger analyzed surface due to larger beam spot-size
- layer-by-layer analysis by energy tuning

#### Numerical simulations for material sample heating









Experimental goals:

- Damage investigation: direct irradiation of a ceramics artifact (6 cm distance from the source)
- PIXE spectroscopy: direct irradiation of a known material sample and X-ray spectrum analysis



Ceramics artifact from AD 1650 (archeological situ of Nicastro), provided by the Cultural Heritage department of Regione Calabria

Chemical analysis: Conventional XRF spectroscopy and Thermoluminescence









✓ PIXE spectroscopy of a Silver sample in one single shot

M. Barberio, S. Veltri, M. Scisciò and P. Antici, Sci. Rep. 7, 40415 (2017)

Patented technique - US 62/166962 (M.Barberio and P.Antici)

#### Work in progress...

Compare laser-driven PIXE with conventional PIXE: induced damage, necessary dose, time necessary for a complete analysis

#### ...future steps.

- Perform PIXE spectroscopy on further materials of interest: marbles, silicates, noble metals, pigments, cellulose
- > Perform PIXE using a lower power laser (i.e. a lower proton flux)
- Layer-by-layer analysis using an energy-selected proton beam
- GEANT4 simulations for PIXE

Proposals for upcoming experiments (2018) sent to JLF-TITAN and LULI-ELFIE.

Collaborations with CENBG/Louvre, Uni. Pisa, INFN Genova.....interest in joining?



#### OPEN Laser-Accelerated Proton Beams as Diagnostics for Cultural Heritage

M. Barberio<sup>1,2</sup>, S. Veltri<sup>1</sup>, M. Scisciò<sup>1,3</sup> & P. Antici<sup>1,3</sup>

This paper introduces the first use of laser-generated proton beams as diagnostic for materials of interest in the domain of Cultural Heritage. Using laser-accelerated protons, as generated by interaction of a high-power short-pulse laser with a solid target, we can produce proton-induced X-ray emission spectroscopies (PIXE). By correctly tuning the proton flux on the sample, we are able to perform the PIXE in a single shot without provoking more damage to the sample than conventional methodologies. We verify this by experimentally irradiating materials of interest in the Cultural Heritage with laser-accelerated protons and measuring the PIXE emission. The morphological and chemical analysis of the sample before and after irradiation are compared in order to assess the damage provoked to the artifact. Montecarlo simulations confirm that the temperature in the sample stays safely below the melting point. Compared to conventional diagnostic methodologies, laser-driven PIXE has the advantage of being potentially quicker and more efficient.



w.nature.com/scientificreports

## Thanking the collaborators...

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### ...and thank you for the attention !

Massimiliano Scisciò massimiliano.sciscio@roma1.infn.it